## Scanning Transmission Electron Microscopy Through-Focal Tilt-Series on Biological Specimens

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Since scanning electron beam can produce high signal-to-noise ratio bright field images of thick specimens, scanning transmission electron microscopy is emerging as the method of choice to study thick (≥ 500 nm) biological samples by tomographic approaches. However, in a convergent beam configuration, the depth-of-field can be rather limited, only a thin portion of the specimen (from a few nanometres to tens of nanometres depending on the convergence angle) is imaged at focus. A way of solving this difficulty is take advantage of raster scanning to get focused images line by line by dynamic focus [1]. However, in our experience, the recovery of full-focused images by dynamic focus, useful for tomographic reconstruction of cells, is impaired at high tilt angles (>45°) in very thick samples (>0.5 nm thickness). To circumvent this limitation we have developed an acquisition scheme and an image processing method in which we reconstruct full-focused images from STEM images recorded at different defocus. The method was applied to compute the 3D reconstruction of the base of the flagellum in the protist Trypanosoma brucei brucei. Our results demonstrate the improvement in the accuracy of the observed details as supported by the analysis of qualitative (visual) and quantitative [2] image descriptors (entropy, RMS contrast and Michelson's contrast).

## References:

1. Feng J, Somlyo AP, Somlyo AV, Shao Z. Automated electron tomography with scanning transmission electron microscopy. J Microsc. 2007 228:406-12.

2. Peli, E., 1990. Contrast in complex images. Journal of the Optical Society of America. A, Optics and image science 7, 2032-2040.

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